Affordable AFM / STM System SOLVER Nano

Advanced Features and Capability for Scientific Research

- Atomic resolution
- More than 30 AFM / STM modes
- Wide range of nanolithography techniques
- Digital controller
- Closed-loop scanner
- Easy adjustments



Delivery set* of SOLVER Nano system:



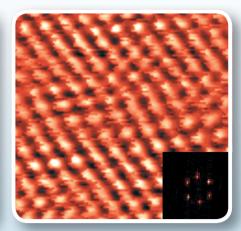




Blood cells. Scan size $50 \times 50 \ \mu m$. Semicontact mode



Microstructure. Scan size 30×30 μm. Semicontact mode



Atomic lattice of HOPG. Scan size 4×4 nm. Contact lateral force mode

Specifications:

Scanning:	By sample, range $100 \times 100 \times 10 \mu\text{m}$ (Closed-loop)
Sample positioning:	Manual, range 5 × 5 mm
Sample weight:	Up to 40 g
Sample size:	Diameter up to 25 mm, Thickness up to 10 mm
Approach system	By sample, motorized, range 10 mm
Optical control:	Built-in USB camera

Modes and Techniques

Atomic Force Microscopy (AFM)

Contact:

- Constant force mode
- Constant height mode

Semicontact:

- Height imaging mode
- Phase imaging mode
- Deflection

Electric Force Microscopy (EFM)
Magnetic Force Microscopy (MFM)
Kelvin Probe Force Microscopy (KPFM)
Scanning Spreading Resistance Microscopy
(SSRM)
Lateral Force Microscopy (LFM)

Scanning Tunneling Microscopy (STM):

- Constant Current mode
- Constant Height mode
- I(Z) Spectroscopy
- I(V) Spectroscopy

Lithographies

- Voltage lithography (AFM/STM)
- Current lithography (AFM/STM)
- Force lithography (scratching, dynamic plowing)

